

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10525130	OH, JEONG-HWAN
	Examiner Lavin, Christopher L	Art Unit 2624

SEARCHED

Class	Subclass	Date	Examiner
382	135,137-140	02/01/07	CLL

SEARCH NOTES

Search Notes	Date	Examiner
East Search	02/01/07	CLL

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner